

ABSTRACT OF DISCLOSURE

An electronic test probe is built including a switch or other control device coupled to the test equipment, such that a user may make a measurement with the probe, and then without moving the probe, activate the control device to change the configuration of the test equipment. This allows a user to make different measurements of the same part of a device without having to remove the probe from the device to change the configuration of the test equipment. Further by configuring the control device to save data or print data from the test equipment, the user may save or print data without removing their hand from the probe.